# PCA9538 Remote 8-Bit I<sup>2</sup>C AND SMBus Low-power I/O Expander with Interrupt **Output, Reset, and Configuration Registers**

#### 1 Features

- Low standby current consumption of 1 µA max
- I<sup>2</sup>C to parallel port expander
- Open-drain active-low interrupt output
- Active-low reset input
- Operating power-supply voltage range of 2.3 V to
- 5-V Tolerant I/O ports
- 400-kHz Fast I<sup>2</sup>C bus
- Two hardware address pins allow up to four devices on the I2C/SMBus
- Input and output configuration register
- Polarity inversion register
- Power-up with all channels configured as inputs
- No glitch on power up
- Noise filter on SCL/SDA inputs
- Latched outputs with high-current drive maximum capability for directly driving LEDs
- Latch-up performance exceeds 100 mA Per JESD 78, class II
- ESD protection exceeds JESD 22
  - 2000-V Human-body model (A114-A)
  - 200-V Machine model (A115-A)
  - 1000-V Charged-device model (C101)

## 2 Description

The PCA9538 is an 8-bit I/O expander of general purpose parallel input and output (I/O) expansion for the two-line bidirectional I<sup>2</sup>C bus (or SMBus) protocol. This device can operate with a power supply range from 2.3 V to 5.5 V. This device supports both 100-kHz (Standard-mode) and 400-kHz (Fast-mode) clock frequencies. This device, along with other I/O expanders, provides a simple solution when additional I/Os are needed for switches, sensors, push-buttons, LEDs, fans, and so on.

The features of PCA9538 include an interrupt that is generated on the INT pin whenever an input port changes state. The A0 and A1 hardware selectable address pins allow up to four PCA9538 devices on the same I<sup>2</sup>C bus. This device can also be reset to its default state by using the RESET feature or by cycling the power supply to cause a power-on reset.

INT can be connected to the interrupt input of a microcontroller. By sending an interrupt signal on this line, the remote I/O can inform the microcontroller if there is incoming data on its ports without having to communicate via the I<sup>2</sup>C bus. Thus, the PCA9538 can remain a simple slave device.

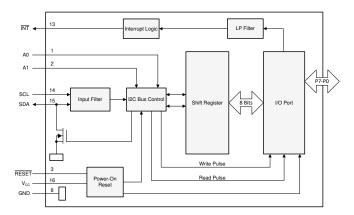
The device outputs (latched) have high-current drive capability for directly driving LEDs. It has low current consumption.

Two hardware pins (A0 and A1) are used to program and vary the fixed I<sup>2</sup>C address and allow up to four devices to share the same I<sup>2</sup>C bus or SMBus.

#### **Device Information**

PART NUMBER	PACKAGE <sup>(1)</sup>	BODY SIZE (NOM)
PCA9538	SSOP (16)	6.20 mm × 5.30 mm
	TVSOP (16)	3.60 mm × 4.40 mm
	SOIC (16)	10.30 mm × 7.50 mm
	TSSOP (16)	5.00 mm × 4.40 mm

For all available packages, see the orderable addendum at the end of the datasheet.



**Block Diagram** 



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3 Revision History Changes from Revision F (May 2014) to Rev	vision G (	March 2021)	Page
<ul> <li>Updated the Description and added the Blo</li> </ul>	ock Diagra	<i>m</i> image	
•	•	guration and Functions section	
· · ·	-	ute Maximum Ratings	
		<del>-</del>	
		mal Resistance Characteristic	
		) Max value From: 5.5 V To: $V_{CC}$ in the <i>Recomme</i>	
•			
		2, P7–P0) MIN value From: 2 V To: 0.7 x V <sub>CC</sub> in th	
		P7–P0) MAX value From: 0.8 V To: 0.3 x $V_{CC}$ in	
• •			
			5
		and the MAX value From: 1.65 V To: 1.5 V in the	_
<ul> <li>Added the V<sub>PORF</sub> row in the Electrical Chara</li> </ul>	acteristics	·	5
<ul> <li>Changed the I<sub>OL</sub> (INT) row TYP value From:</li> </ul>	: 10 mA to	o: 7 mA in the Electrical Characteristics	5
· · · · ·		cal Characteristics	
• • •		e (5.5 V) mAX value From: 1 mA To: 4 mA in the	
		5 (0.5 V) TIAX Value 1 TOTIL 1 TIA TO. 4 TIA III TIE	5
· Added Note 4 to the Electrical Characteristi	ics		5
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Added Interrupt Errata section .......17



# **4 Pin Configuration and Functions**

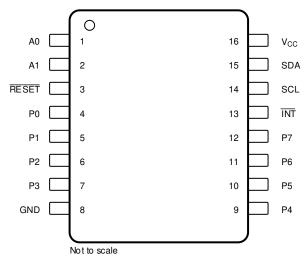


Figure 4-1. DBQ, DB, PW, DGV Package, 16-Pin, Top View

Table 4-1. Pin Functions

	PIN	DESCRIPTION		
NAME	NO.	DESCRIPTION		
A0	1	Address input. Connect directly to V <sub>CC</sub> or ground		
A1	2	Address input. Connect directly to V <sub>CC</sub> or ground.		
GND	8	Ground		
ĪNT	13	Interrupt output. Connect to V <sub>CC</sub> through a pullup resistor		
P0	4	P-port input-output. Push-pull design structure		
P1	5	P-port input-output. Push-pull design structure		
P2	6	P-port input-output. Push-pull design structure		
P3	7	P-port input-output. Push-pull design structure		
P4	9	P-port input-output. Push-pull design structure		
P5	10	P-port input-output. Push-pull design structure		
P6	11	P-port input-output. Push-pull design structure		
P7	12	P-port input-output. Push-pull design structure		
RESET	3	Active-low reset input. Connect to V <sub>CC</sub> through a pullup resistor if no active connection is used		
SCL	14	Serial clock bus. Connect to V <sub>CC</sub> through a pullup resistor		
SDA	15	Serial data bus. Connect to V <sub>CC</sub> through a pullup resistor		
V <sub>CC</sub>	16	Supply voltage		



## **5 Specifications**

## **5.1 Absolute Maximum Ratings**

over operating free-air temperature range (unless otherwise noted) (1)

	-		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		-0.5	6	V
VI	Input voltage <sup>(2)</sup>		-0.5	6	V
Vo	Output voltage <sup>(2)</sup>		-0.5	6	V
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-20	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-20	mA
I <sub>IOK</sub>	Input/output clamp current	$V_O < 0$ or $V_O > V_{CC}$		±20	mA
I <sub>OL</sub>	Continuous output low current	$V_O = 0$ to $V_{CC}$		50	mA
I <sub>OH</sub>	Continuous output high current	$V_O = 0$ to $V_{CC}$		-50	mA
	Continuous current through GND			-250	mA.
I <sub>CC</sub>	Continuous current through V <sub>CC</sub>			160	1 IIIA
T <sub>stg</sub>	Storage temperature		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 5.2 ESD Ratings

				MIN	MAX	UNIT
	,	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	0	2000	V
Ľ	(ESD)	Liectiostatic discriarge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins <sup>(2)</sup>	0	1000	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

## **5.3 Recommended Operating Conditions**

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		2.3	5.5	V
.,	High level input voltage	SCL, SDA	0.7 × V <sub>CC</sub>	V <sub>CC</sub>	\/
V IH	V <sub>IH</sub> High-level input voltage	A0, A1, RESET, P7-P0	0.7 × V <sub>CC</sub>	5.5	V
.,	Low-level input voltage	SCL, SDA	-0.5	0.3 × V <sub>CC</sub>	V
V <sub>IL</sub>	Low-level input voltage	A0, A1, RESET, P7-P0	-0.5	0.3 × V <sub>CC</sub>	V
I <sub>OH</sub>	High-level output current	P7–P0		-10	mA
I <sub>OL</sub>	Low-level output current	P7–P0		25	mA
T <sub>A</sub>	Operating free-air temperature		-40	85	°C

Product Folder Links: PCA9538

<sup>(2)</sup> The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



## **5.4 Thermal Information**

				PCA9538			
THERMAL METRIC(1)		DB (SSOP)	DBQ (SSOP)	DGV (TVSOP)	DW (SOIC)	PW (TSSOP)	UNIT
		16 PINS	16 PINS	16 PINS	16 PINS	16 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	113.2	90	86	46	122	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC package thermal metrics application report.

### 5.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>IK</sub>	Input diode clamp voltage	I <sub>I</sub> = -18 mA	2.3 V to 5.5 V	-1.2			V
V <sub>PORR</sub>	Power-on reset voltage, V <sub>CC</sub> rising	$V_I = V_{CC}$ or GND, $I_O = 0$			1.2	1.5	V
V <sub>PORF</sub>	Power-on reset voltage, V <sub>C7</sub> falling	V <sub>I</sub> = V <sub>CC</sub> or GND, I <sub>O</sub> = 0		0.75	1		V
			2.3 V	1.8			
		0.554	3 V	2.6			
		$I_{OH} = -8 \text{ mA}$	4.5 V	4.1			
V <sub>OH</sub>	D	4 himb lavel avidavid valda na (2)	4.75 V	4.1			.,
	P-port high-level output voltage <sup>(2)</sup>	evel output voltage -/	2.3 V	1.7			V
		10 1	3 V	2.5			
		I <sub>OH</sub> = -10 mA	4.5 V	4			
			4.75 V	4			
	SDA	V <sub>OL</sub> = 0.4 V	2.3 V to 5.5 V	3	8		
	P port <sup>(3)</sup>		2.3 V	8	10		
			3 V	8	14		
		V <sub>OL</sub> = 0.5 V	4.5 V	8	17		
			4.75 V	8	35		
I <sub>OL</sub>		V <sub>OL</sub> = 0.7 V	2.3 V	10	13		mA
			3 V	10	19		
			4.5 V	10	24		
			4.75 V	10	45		
	INT	V <sub>OL</sub> = 0.4 V	2.3 V to 5.5 V	3	7		
	SCL, SDA	V = V = an CND	227/4- 557/			±1	
I <sub>I</sub>	A0, A1, RESET (4)	$V_I = V_{CC}$ or GND	2.3 V to 5.5 V			±1	μA
I <sub>IH</sub>	P port	V <sub>I</sub> = V <sub>CC</sub>	2.3 V to 5.5 V			1	μA
I <sub>IL</sub>	P port	V <sub>I</sub> = GND	2.3 V to 5.5 V			-1	μA
			5.5 V		104	175	
		$V_I = V_{CC}$ or GND, $I_O = 0$ , $I/O = \text{inputs}$ , $f_{scl} = 400 \text{ kHz}$ , no load	3.6 V		50	90	
	On white was de	I/O = Inputs, I <sub>scl</sub> = 400 KHz, No load	2.7 V		20	65	
	Operating mode		5.5 V		60	150	
I <sub>CC</sub>		$V_I = V_{CC}$ or GND, $I_O = 0$ , $I/O = \text{inputs}$ , $f_{scl} = 100 \text{ kHz}$ , no load	3.6 V		15	40	μΑ
		inputs, isci – 100 ki iz, ilo load	2.7 V		8	20	
			5.5 V		1.9	3.5	
	Standby mode	$V_1 = V_{CC}$ or GND, $I_0 = 0$ ,	3.6 V		1.1	1.8	
		I/O = inputs, f <sub>scl</sub> = 0 kHz, no load	2.7 V		1	1.6	

## **5.5 Electrical Characteristics (continued)**

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	V <sub>CC</sub>	MIN	TYP <sup>(1)</sup>	MAX	UNIT
ΔI <sub>CC</sub>	Additional current in standby mode	One input at $V_{CC}$ – 0.6 V, Other inputs at $V_{CC}$ or GND	2.3 V to 5.5 V			1.5	mΛ
		All LED I/Os at $V_I = 4.3 \text{ V}$ , $f_{\text{scl}} = 0 \text{ kHz}$	5.5 V			4	mA
Ci	SCL	V <sub>I</sub> = V <sub>CC</sub> or GND	2.3 V to 5.5 V		4	5	pF
C	SDA	V <sub>IO</sub> = V <sub>CC</sub> or GND	2.3 V to 5.5 V		5.5	6.5	pF
C <sub>io</sub>	P port	NIO - VCC OI GIVD	2.5 V to 5.5 V		8	9.5	рі

- (1) All typical values are at nominal supply voltage (2.5-, 3.3-, or 5-V  $V_{CC}$ ) and  $T_A$  = 25°C.
- (2) The total current sourced by all I/Os must be limited to 85 mA.
- (3) Each I/O must be externally limited to a maximum of 25 mA, and the P port (P7–P0) must be limited to a maximum current of 200 mA.
- (4) RESET =  $V_{CC}$  (held high) when all other input voltages,  $V_I$  = GND.

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# 5.6 I<sup>2</sup>C Interface Timing Requirements

over operating free-air temperature range (unless otherwise noted) (see Figure 6-1)

			MIN	MAX	UNIT
STANDA	RD MODE				
f <sub>scl</sub>	I <sup>2</sup> C clock frequency		0	100	kHz
t <sub>sch</sub>	I <sup>2</sup> C clock high time		4		μs
t <sub>scl</sub>	I <sup>2</sup> C clock low time		4.7		μs
t <sub>sp</sub>	I <sup>2</sup> C spike time			50	ns
t <sub>sds</sub>	I <sup>2</sup> C serial-data setup time		250		ns
t <sub>sdh</sub>	I <sup>2</sup> C serial-data hold time		0		ns
t <sub>icr</sub>	I <sup>2</sup> C input rise time			1000	ns
t <sub>icf</sub>	I <sup>2</sup> C input fall time			300	ns
t <sub>ocf</sub>	I <sup>2</sup> C output fall time	10-pF to 400-pF bus		300	ns
t <sub>buf</sub>	I <sup>2</sup> C bus free time between Stop and Start		4.7		μs
t <sub>sts</sub>	I <sup>2</sup> C Start or repeated Start condition setup		4.7		μs
t <sub>sth</sub>	I <sup>2</sup> C Start or repeated Start condition hold		4		μs
t <sub>sps</sub>	I <sup>2</sup> C Stop condition setup		4		μs
t <sub>vd(data)</sub>	Valid data time	SCL low to SDA output valid	300		ns
t <sub>vd(ack)</sub>	Valid data time of ACK condition	ACK signal from SCL low to SDA (out) low	0.3	3.45	μs
C <sub>b</sub>	I <sup>2</sup> C bus capacitive load	1		400	ns
FAST MO	DDE				
f <sub>scl</sub>	I <sup>2</sup> C clock frequency		0	400	kHz
t <sub>sch</sub>	I <sup>2</sup> C clock high time		0.6		μs
t <sub>scl</sub>	I <sup>2</sup> C clock low time		1.3		μs
t <sub>sp</sub>	I <sup>2</sup> C spike time			50	ns
t <sub>sds</sub>	I <sup>2</sup> C serial-data setup time		100		ns
t <sub>sdh</sub>	I <sup>2</sup> C serial-data hold time		0		ns
t <sub>icr</sub>	I <sup>2</sup> C input rise time		20 + 0.1C <sub>b</sub> (1)	300	ns
t <sub>icf</sub>	I <sup>2</sup> C input fall time		20 + 0.1C <sub>b</sub>	300	ns
t <sub>ocf</sub>	I <sup>2</sup> C output fall time	10-pF to 400-pF bus	20 + 0.1C <sub>b</sub>	300	ns
t <sub>buf</sub>	I <sup>2</sup> C bus free time between Stop and Start		1.3		μs
t <sub>sts</sub>	I <sup>2</sup> C Start or repeated Start condition setup		0.6		μs
t <sub>sth</sub>	I <sup>2</sup> C Start or repeated Start condition hold		0.6		μs
t <sub>sps</sub>	I <sup>2</sup> C Stop condition setup		0.6		μs
t <sub>vd(data)</sub>	Valid data time	SCL low to SDA output valid	50		ns
t <sub>vd(ack)</sub>	Valid data time of ACK condition	ACK signal from SCL low to SDA (out) low	0.1	0.9	μs
C <sub>b</sub>	I <sup>2</sup> C bus capacitive load	1		400	ns

<sup>(1)</sup> C<sub>b</sub> = Total capacitance of one bus in pF



## **5.7 RESET Timing Requirements**

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	MIN	MAX	UNIT					
STANDARD	STANDARD MODE and FAST MODE								
t <sub>W</sub>	Reset pulse duration	4		ns					
t <sub>REC</sub>	Reset recovery time	0		ns					
t <sub>RESET</sub>	Time to reset	400		ns					

## **5.8 Switching Characteristics**

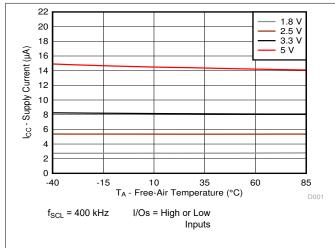
over operating free-air temperature range (unless otherwise noted) (see Figure 6-2 and Figure 6-3)

	PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN MAX	UNIT					
STAN	STANDARD MODE and FAST MODE									
tiv	Interrupt valid time	P port	ĪNT	4	μs					
t <sub>ir</sub>	Interrupt reset delay time	SCL	ĪNT	4	μs					
t <sub>pv</sub>	Output data valid	SCL	P7-P0	200	ns					
t <sub>ps</sub>	Input data setup time	P port	SCL	100	ns					
t <sub>ph</sub>	Input data hold time	P port	SCL	1	μs					

Product Folder Links: PCA9538

## 5.9 Typical Characteristics

T<sub>A</sub> = 25°C (unless otherwise noted)



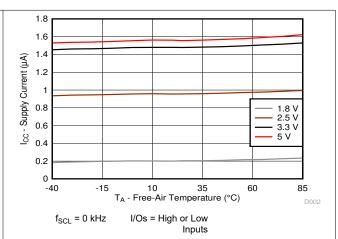
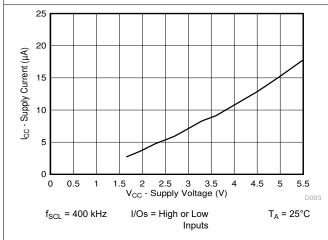


Figure 5-1. Supply Current (I<sub>CC</sub>, Operating Mode) vs Temperature (T<sub>A</sub>) at Four Supply Voltages

Figure 5-2. Supply Current (ICC, Standby Mode) vs Temperature (T<sub>A</sub>) at Four Supply Voltages



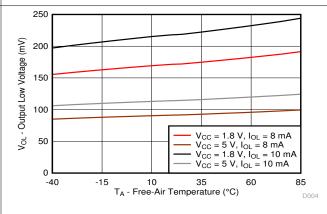
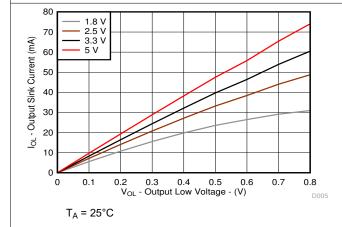


Figure 5-3. Supply Current ( $I_{CC}$ , Operating Mode) vs Supply Voltage ( $V_{CC}$ )

Figure 5-4. Output Low Voltage ( $V_{OL}$ ) vs Temperature ( $T_A$ ) for P-Port I/Os



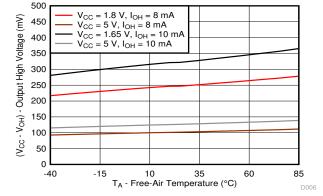


Figure 5-5. Sink Current ( $I_{OL}$ ) vs Output Low Voltage ( $V_{OL}$ ) for P-Ports at Four Supply Voltages

Figure 5-6. Output High Voltage ( $V_{CC} - V_{OH}$ ) vs Temperature ( $T_A$ ) for P-Ports



## **5.9 Typical Characteristics (continued)**

T<sub>A</sub> = 25°C (unless otherwise noted)

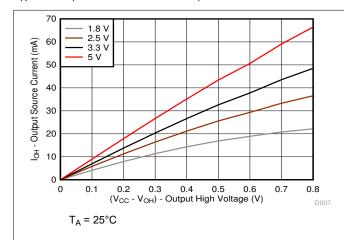


Figure 5-7. Source Current (I<sub>OH</sub>) vs Output High Voltage (V<sub>OH</sub>) for P-Ports at Four Supply Voltages

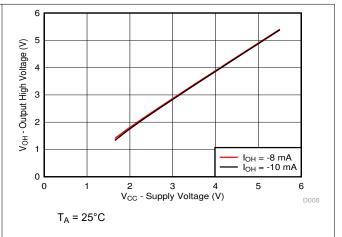
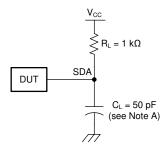


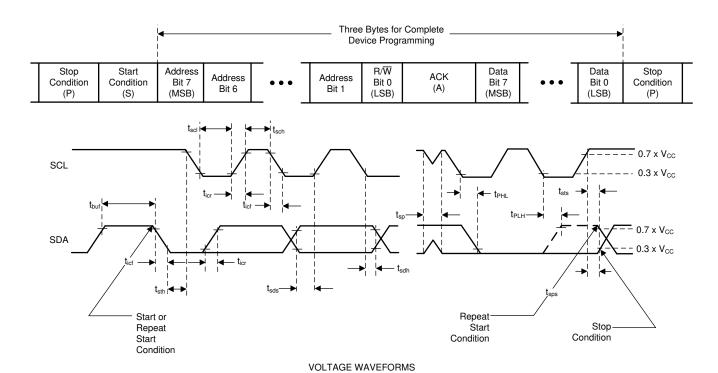
Figure 5-8. Output High Voltage ( $V_{CC}$ ) vs Supply Voltage ( $V_{CC}$ ) for P-Ports



## **6 Parameter Measurement Information**



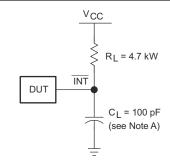
SDA LOAD CONFIGURATION



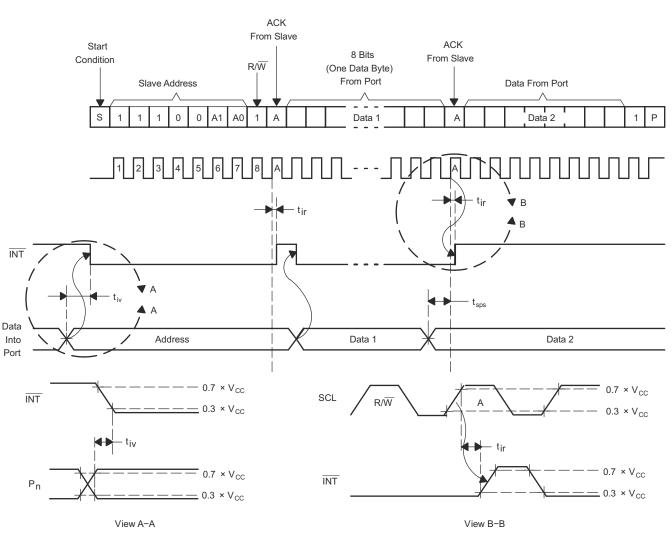
- A.  $C_L$  includes probe and jig capacitance.
- B. All inputs are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_0$  = 50  $\Omega$ ,  $t_r/t_f \leq$  30 ns.
- C. All parameters and waveforms are not applicable to all devices.

Figure 6-1. I<sup>2</sup>C Interface Load Circuit and Voltage Waveforms





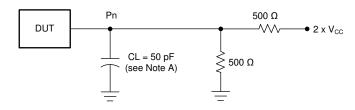
INTERRUPT LOAD CONFIGURATION



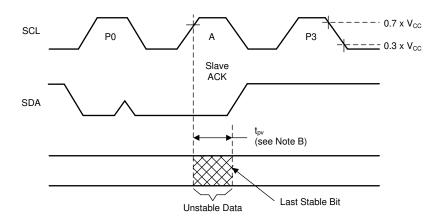
- A. C<sub>L</sub> includes probe and jig capacitance.
- B. All inputs are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_{O}$  = 50  $\Omega$ ,  $t_{r}/t_{f}$   $\leq$  30 ns.
- C. All parameters and waveforms are not applicable to all devices.

Figure 6-2. Interrupt Load Circuit and Voltage Waveforms

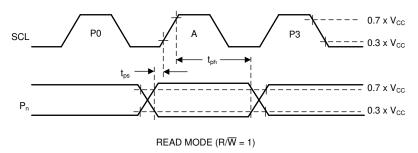




P-PORT LOAD CONFIGURATION



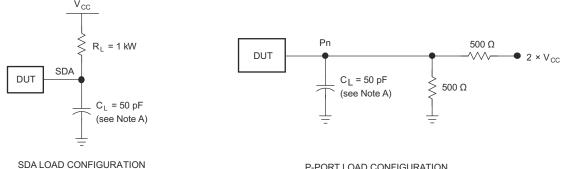
WRITE MODE  $(R/\overline{W} = 0)$ 



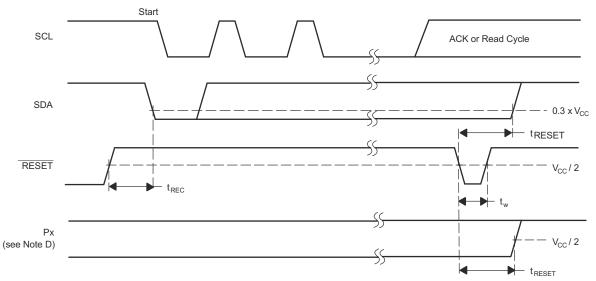
- A. C<sub>L</sub> includes probe and jig capacitance.
- B. All inputs are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_0$  = 50  $\Omega$ ,  $t_r/t_f \leq$  30 ns.
- C. The outputs are measured one at a time, with one transition per measurement.
- D. All parameters and waveforms are not applicable to all devices.

Figure 6-3. P-Port Load Circuit and Voltage Waveforms





P-PORT LOAD CONFIGURATION

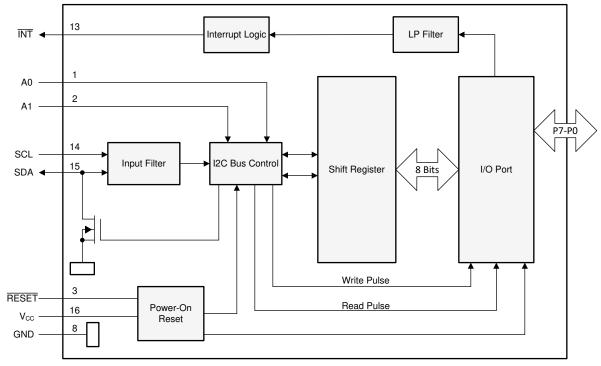


- A. C<sub>L</sub> includes probe and jig capacitance.
- B. All inputs are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \ \Omega$ ,  $t_r/t_f \leq 30 \ ns$ .
- C. The outputs are measured one at a time, with one transition per measurement.
- D. I/Os are configured as inputs.
- E. All parameters and waveforms are not applicable to all devices.

Figure 6-4. Reset Load Circuits and Voltage Waveforms

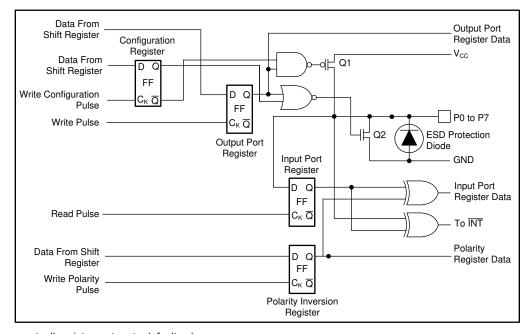
## 7 Detailed Description

## 7.1 Functional Block Diagram



Pin numbers shown are for the DB, DBQ, DGV, DW, or PW package.

Figure 7-1. Functional Block Diagram



At power-on reset, all registers return to default values.

Figure 7-2. Simplified Schematic Of P0 To P7



#### 7.2 Device Functional Modes

## 7.2.1 RESET Input

The  $\overline{RESET}$  input can be asserted to reset the system while keeping the  $V_{CC}$  at its operating level. A reset can be accomplished by holding the  $\overline{RESET}$  pin low for a minimum of  $t_W$ . The PCA9538 registers and I<sup>2</sup>C/SMBus state machine are changed to their default states once  $\overline{RESET}$  is low (0). Once  $\overline{RESET}$  is high (1), the I/O levels at the P port can be changed externally or through the master. This input requires a pullup resistor to  $V_{CC}$  if no active connection is used.

#### 7.2.1.1 RESET Errata

If RESET voltage set higher than VCC, current flows from RESET pin to VCC pin.

#### **System Impact**

VCC is pulled above its regular voltage level.

#### **System Workaround**

Design such that RESET voltage is same or lower than VCC.

#### 7.2.2 Power-On Reset

When power (from 0 V) is applied to  $V_{CC}$ , an internal power-on reset holds the PCA9538 in a reset condition until  $V_{CC}$  has reached  $V_{POR}$ . At that point, the reset condition is released and the PCA9538 registers and  $I^2C/SMBus$  state machine initialize to their default states. After that,  $V_{CC}$  must be lowered to below 0.2 V and then back up to the operating voltage for a power-reset cycle.

#### 7.2.3 I/O Port

When an I/O is configured as an input, FETs Q1 and Q2 (in Figure 7-2) are off, creating a high-impedance input. The input voltage may be raised above  $V_{CC}$  to a maximum of 5.5 V.

If the I/O is configured as an output, Q1 or Q2 is enabled depending on the state of the output port register. In this case, there are low impedance paths between the I/O pin and either  $V_{CC}$  or GND. The external voltage applied to this I/O pin must not exceed the recommended levels for proper operation.

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## 7.2.4 Interrupt Output ( INT)

An interrupt is generated by any rising or falling edge of the port inputs in the input mode. After time,  $t_{iv}$ , the signal  $\overline{INT}$  is valid. Resetting the interrupt circuit is achieved when data on the port is changed to the original setting, data is read from the port that generated the interrupt. Resetting occurs in the read mode at the acknowledge (ACK) or not acknowledge (NACK) bit after the rising edge of the SCL signal.

Interrupts that occur during the ACK or NACK clock pulse can be lost (or be very short) due to the resetting of the interrupt during this pulse. Each change of the I/Os after resetting is detected and is transmitted as  $\overline{\text{INT}}$ . Writing to another device does not affect the interrupt circuit, and a pin configured as an output cannot cause an interrupt. Changing an I/O from an output to an input may cause a false interrupt to occur, if the state of the pin does not match the contents of the Input Port register. Because each 8-pin port is read independently, the interrupt caused by port 0 is not cleared by a read of port 1 or vice versa.

The INT output has an open-drain structure and requires pullup resistor to V<sub>CC</sub>.

## 7.2.4.1 Interrupt Errata

The INT will be improperly de-asserted if the following two conditions occur:

1. The last I<sup>2</sup>C command byte (register pointer) written to the device was 00h.

#### Note

This generally means the last operation with the device was a Read of the input register. However, the command byte may have been written with 00h without ever going on to read the input register. After reading from the device, if no other command byte written, it remains 00h.

2. Any other slave device on the I<sup>2</sup>C bus acknowledges an address byte with the R/W bit set high

#### System Impact

Can cause improper interrupt handling as the Master sees the interrupt as being cleared.

#### **System Workaround**

Minor software change: User must change command byte to something besides 00h after a Read operation to the PCA9538 device or before reading from another slave device.

#### Note

Software change are compatible with other versions (competition and TI redesigns) of this device.

## 7.3 Programming

#### 7.3.1 I<sup>2</sup>C Interface

The bidirectional I<sup>2</sup>C bus consists of the serial clock (SCL) and serial data (SDA) lines. Both lines must be connected to a positive supply through a pull-up resistor when connected to the output stages of a device. Data transfer may be initiated only when the bus is not busy.

I<sup>2</sup>C communication with this device is initiated by a master sending a Start condition, a high-to-low transition on the SDA input/output while the SCL input is high (see Figure 7-3). After the Start condition, the device address byte is sent, most significant bit (MSB) first, including the data direction bit (R/ $\overline{W}$ ).

After receiving the valid address byte, this device responds with an acknowledge (ACK), a low on the SDA input/output during the high of the ACK-related clock pulse. The address inputs (A0–A1) of the slave device must not be changed between the Start and the Stop conditions.

On the I<sup>2</sup>C bus, only one data bit is transferred during each clock pulse. The data on the SDA line must remain stable during the high pulse of the clock period, as changes in the data line at this time are interpreted as control commands (Start or Stop) (see Figure 7-4).

A Stop condition, a low-to-high transition on the SDA input/output while the SCL input is high, is sent by the master (see Figure 7-3).

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Any number of data bytes can be transferred from the transmitter to receiver between the Start and the Stop conditions. Each byte of eight bits is followed by one ACK bit. The transmitter must release the SDA line before the receiver can send an ACK bit. The device that acknowledges must pull down the SDA line during the ACK clock pulse so that the SDA line is stable low during the high pulse of the ACK-related clock period (see Figure 7-5). When a slave receiver is addressed, it must generate an ACK after each byte is received. Similarly, the master must generate an ACK after each byte that it receives from the slave transmitter. Setup and hold times must be met to ensure proper operation.

A master receiver signals an end of data to the slave transmitter by not generating an acknowledge (NACK) after the last byte has been clocked out of the slave. This is done by the master receiver by holding the SDA line high. In this event, the transmitter must release the data line to enable the master to generate a Stop condition.

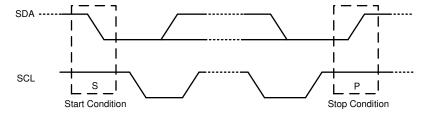


Figure 7-3. Definition Of Start And Stop Conditions

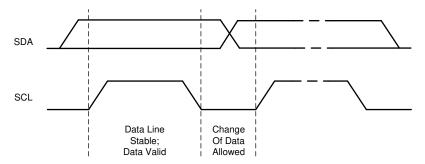


Figure 7-4. Bit Transfer

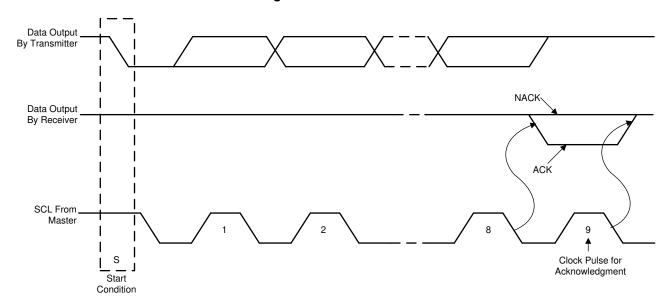


Figure 7-5. Acknowledgment On I<sup>2</sup>C Bus



## 7.4 Register Maps

Table 7-1 shows the address byte of the PCA9538.

**Table 7-1. Interface Definition Table** 

ВҮТЕ		BIT										
	7 (MSB)	6	5	4	3	2	1	0 (LSB)				
I <sup>2</sup> C slave address	Н	Н	Н	L	L	A1	A0	R/W				
Px I/O data bus	P7	P6	P5	P4	P3	P2	P1	P0				

### 7.4.1 Device Address

Figure 7-6 shows the address byte of the PCA9538.

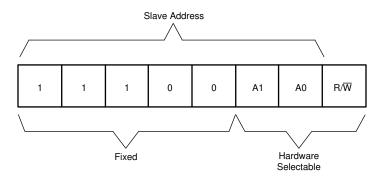


Figure 7-6. PCA9538 Address

Table 7-2 shows the PCA9538 address reference.



Table 7-2. Address Reference Table

INP	UTS	I <sup>2</sup> C BUS SLAVE ADDRESS
A1	A0	1 C BOS SLAVE ADDRESS
L	L	112 (decimal), 70 (hexadecimal)
L	Н	113 (decimal), 71 (hexadecimal)
Н	L	114 (decimal), 72 (hexadecimal)
Н	Н	115 (decimal), 73 (hexadecimal)

The last bit of the slave address defines the operation (read or write) to be performed. When it is high (1), a read is selected while a low (0) selects a write operation.

#### 7.4.2 Control Register And Command Byte

Following the successful Acknowledgment of the address byte, the bus master sends a command byte that is stored in the control register in the PCA9538 (see Figure 7-7). Two bits of this command byte state the operation (read or write) and the internal register (input, output, polarity inversion or configuration) that are affected. This register can be written or read through the I<sup>2</sup>C bus. The command byte is sent only during a write transmission.

Once a command byte has been sent, the register that was addressed continues to be accessed by reads until a new command byte has been sent.

Figure 7-7 shows the PCA9538 control register bits and Table 7-3 shows the command byte.

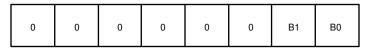


Figure 7-7. Control Register Bits

Table 7-3. Command Byte Table

CONTROL REG	SISTER BITS	COMMAND BYTE	REGISTER	PROTOCOL	POWER-UP DEFAULT
B1	В0	(HEX)	REGISTER	PROTOCOL	FOWER-OF DEFAULT
0	0	0×00	Input Port	Read byte	XXXX XXXX
0	1	0×01	Output Port	Read/write byte	1111 1111
1	0	0×02	Polarity Inversion	Read/write byte	0000 0000
1	1	0×03	Configuration	Read/write byte	1111 1111

Product Folder Links: PCA9538

### 7.4.3 Register Descriptions

The Input Port register (register 0) reflects the incoming logic levels of the pins, regardless of whether the pin is defined as an input or an output by the Configuration register. It only acts on read operation. Writes to these registers have no effect. The default value, X, is determined by the externally applied logic level.

Before a read operation, a write transmission is sent with the command byte to indicate to the I<sup>2</sup>C device that the Input Port register is accessed next. See Table 7-4.

Table 7-4. Register 0 (Input Port Register) Table

			•	•		,		
BIT	17	16	15	14	13	12	I1	10
DEFAULT	Х	Х	Х	Х	Х	Х	Х	Х

The Output Port register (register 1) shows the outgoing logic levels of the pins defined as outputs by the Configuration register. Bit values in this register have no effect on pins defined as inputs. In turn, reads from this register reflect the value that is in the flip-flop controlling the output selection, not the actual pin value. See Table 7-5.

Table 7-5. Register 1 (Output Port Register) Table

			•			,		
BIT	07	O6	O5	04	O3	02	01	00
DEFAULT	1	1	1	1	1	1	1	1

The Polarity Inversion register (register 2) allows polarity inversion of pins defined as inputs by the Configuration register. If a bit in this register is set (written with 1), the corresponding port pin polarity is inverted. If a bit in this register is cleared (written with a 0), the corresponding port pin original polarity is retained. See Table 7-6.

Table 7-6. Register 2 (Polarity Inversion Register) Table

BIT	N7	N6	N5	N4	N3	N2	N1	N0
DEFAULT	0	0	0	0	0	0	0	0

The Configuration register (register 3) configures the directions of the I/O pins. If a bit in this register is set to 1, the corresponding port pin is enabled as an input with a high-impedance output driver. If a bit in this register is cleared to 0, the corresponding port pin is enabled as an output. See Table 7-7.

Table 7-7. Register 3 (Configuration Register) Table

BIT	C7	C6	C5	C4	C3	C2	C1	C0
DEFAULT	1	1	1	1	1	1	1	1

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#### 7.4.4 Bus Transactions

Data is exchanged between the master and PCA9538 through write and read commands.

#### 7.4.4.1 Writes

Data is transmitted to the PCA9538 by sending the device address and setting the least-significant bit (LSB) to a logic 0 (see Figure 7-6 for device address). The command byte is sent after the address and determines which register receives the data that follows the command byte (see Figure 7-8 and Figure 7-9). There is no limitation on the number of data bytes sent in one write transmission.

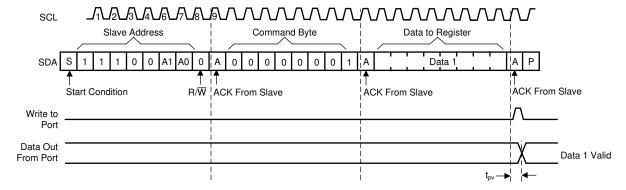


Figure 7-8. Write To Output Port Register

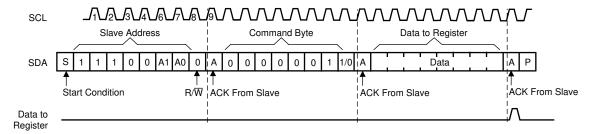


Figure 7-9. Write To Configuration Or Polarity Inversion Registers

Product Folder Links: PCA9538

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#### 7.4.4.2 Reads

The bus master first must send the PCA9538 address with the LSB set to a logic 0 (see Figure 7-6 for device address). The command byte is sent after the address and determines which register is accessed. After a restart, the device address is sent again but, this time, the LSB is set to a logic 1. Data from the register defined by the command byte then is sent by the PCA9538 (see Figure 7-10 and Figure 7-11). After a restart, the value of the register defined by the command byte matches the register being accessed when the restart occurred. Data is clocked into the register on the rising edge of the ACK clock pulse. There is no limitation on the number of data bytes received in one read transmission, but when the final byte is received, the bus master must not acknowledge the data.

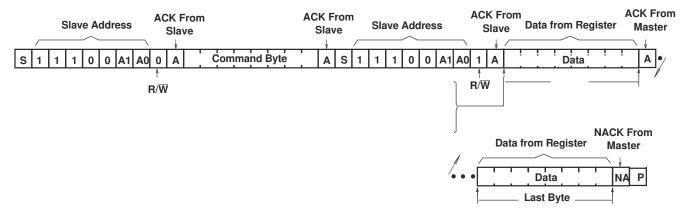
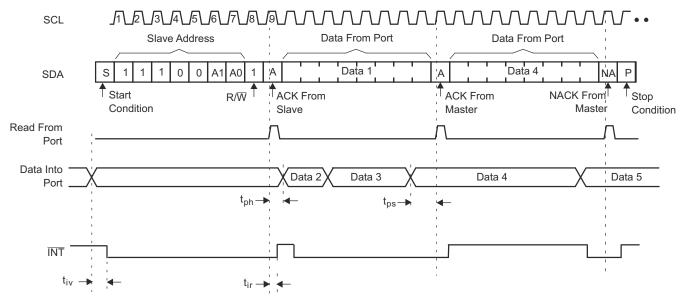


Figure 7-10. Read From Register



- A. This figure assumes the command byte has previously been programmed with 00h.
- B. Transfer of data can be stopped at any moment by a Stop condition.
- C. This figure eliminates the command byte transfer, a restart, and slave address call between the initial slave address call and actual data transfer from the P port. See Figure 7-10 for these details.

Figure 7-11. Read From Input Port Register

## **8 Application Information Disclaimer**

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

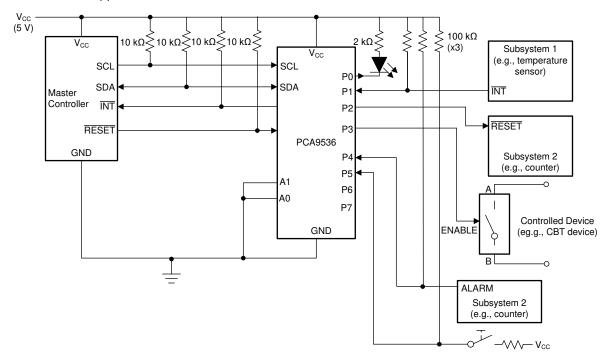
## 8.1 Application Information Disclaimer

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

## 8.2 Typical Application

Figure 8-1 shows an application in which the PCA9538 can be used.



- A. Device address is configured as 1110000 for this example.
- B. P0, P2, and P3 are configured as outputs.
- C. P1, P4, and P5 are configured as inputs.
- D. P6 and P7 are not used and must be configured as outputs.

Figure 8-1. Typical Application

### 8.2.1 Detailed Design Procedure

## 8.2.1.1 Minimizing I<sub>CC</sub> When I/Os Control Leds

When the I/Os are used to control LEDs, normally they are connected to  $V_{CC}$  through a resistor as shown in Figure 8-1. The LED acts as a diode, so when the LED is off, the I/O  $V_{IN}$  is about 1.2 V less than  $V_{CC}$ . I<sub>CC</sub> in Electrical Characteristics shows how I<sub>CC</sub> increases as  $V_{IN}$  becomes lower than  $V_{CC}$ .

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For battery-powered applications, it is essential that the voltage of I/O pins is greater than or equal to  $V_{CC}$  when the LED is off to minimize current consumption. Figure 8-2 shows a high-value resistor in parallel with the LED. Figure 8-3 shows  $V_{CC}$  less than the LED supply voltage by at least 1.2 V. Both of these methods maintain the I/O  $V_{IN}$  at or above  $V_{CC}$  and prevents additional supply current consumption when the LED is off.

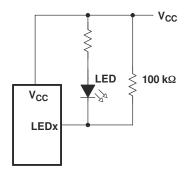


Figure 8-2. High-Value Resistor in Parallel with Led

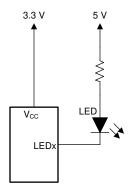


Figure 8-3. Device Supplied by a Lower Voltage



## 9 Power Supply Recommendations

## 9.1 Power-On Reset Requirements

In the event of a glitch or data corruption, PCA9538 can be reset to its default conditions by using the power-on reset feature. Power-on reset requires that the device go through a power cycle to be completely reset. This reset also happens when the device is powered on for the first time in an application.

The two types of power-on reset are shown in Figure 9-1 and Figure 9-2.

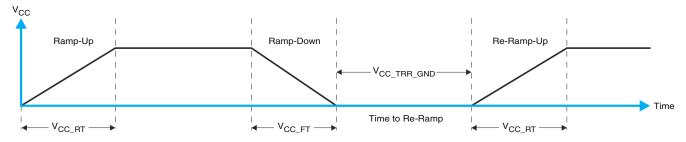


Figure 9-1.  $V_{CC}$  Is Lowered Below 0.2 V Or 0 V And Then Ramped Up To  $V_{CC}$ 

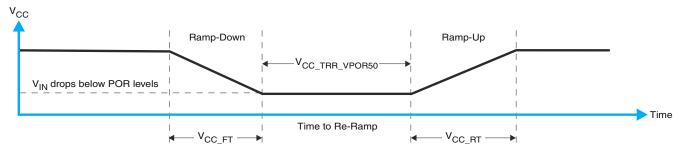


Figure 9-2. V<sub>CC</sub> Is Lowered Below The Por Threshold, Then Ramped Back Up To V<sub>CC</sub>

Table 9-1 specifies the performance of the power-on reset feature for PCA9538 for both types of power-on reset.

Table 9-1. Recommended	Sunnly	Seguencing	And Ramn	Ratos (1)
Table 3-1. Recollillended	SUDDIV	Seduencina	Allu Kallib i	Rales ''

	PARAMETER		MIN	TYP	MAX	UNIT
V <sub>CC_FT</sub>	Fall rate	See Figure 9-1	1		100	ms
V <sub>CC_RT</sub>	Rise rate	See Figure 9-1	0.01		100	ms
V <sub>CC_TRR_GND</sub>	Time to re-ramp (when V <sub>CC</sub> drops to GND)	See Figure 9-1	0.001			ms
V <sub>CC_TRR_POR50</sub>	Time to re-ramp (when V <sub>CC</sub> drops to V <sub>POR_MIN</sub> – 50 mV)	See Figure 9-2	0.001			ms
V <sub>CC_GH</sub>	Level that $V_{CCP}$ can glitch down to, but not cause a functional disruption when $V_{CCX\_GW}$ = 1 $\mu s$	See Figure 9-3			1.2	٧
V <sub>CC_GW</sub>	Glitch width that will not cause a functional disruption when $V_{CCX\_GH} = 0.5 \times V_{CCx}$	See Figure 9-3				μs
V <sub>PORF</sub>	Voltage trip point of POR on falling V <sub>CC</sub>		0.767		1.144	V
V <sub>PORR</sub>	Voltage trip point of POR on rising $V_{CC}$		1.033		1.428	V

(1)  $T_A = -40$ °C to 85°C (unless otherwise noted)

Glitches in the power supply can also affect the power-on reset performance of this device. The glitch width  $(V_{CC\_GW})$  and height  $(V_{CC\_GH})$  are dependent on each other. The bypass capacitance, source impedance, and the device impedance are factors that affect power-on reset performance. Figure 9-3 and Table 9-1 provide more information on how to measure these specifications.

Product Folder Links: *PCA9538* 

V<sub>CC\_GW</sub>

Figure 9-3. Glitch Width And Glitch Height

 $V_{POR}$  is critical to the power-on reset.  $V_{POR}$  is the voltage level at which the reset condition is released and all the registers and the I<sup>2</sup>C/SMBus state machine are initialized to their default states. The value of  $V_{POR}$  differs based on the  $V_{CC}$  being lowered to or from 0. Figure 9-4 and Table 9-1 provide more details on this specification.

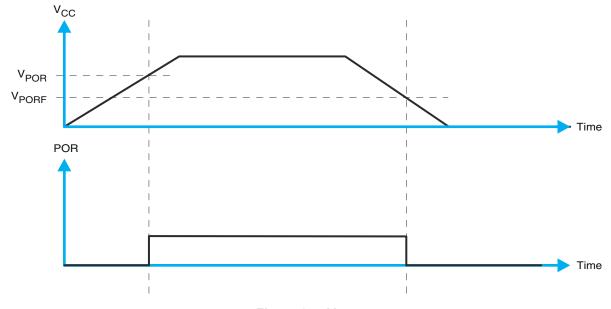


Figure 9-4. V<sub>POR</sub>



## 10 Device and Documentation Support

## 10.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 10.2 Support Resources

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## 10.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 10.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

## 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Product Folder Links: PCA9538



www.ti.com 4-Nov-2023

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
PCA9538DB	LIFEBUY	SSOP	DB	16	80	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD538	
PCA9538DGVR	LIFEBUY	TVSOP	DGV	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD538	
PCA9538DW	LIFEBUY	SOIC	DW	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PCA9538	
PCA9538DWR	LIFEBUY	SOIC	DW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PCA9538	
PCA9538PWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	PD538	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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# **PACKAGE OPTION ADDENDUM**

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# **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
PCA9538DGVR	TVSOP	DGV	16	2000	330.0	12.4	6.8	4.0	1.6	8.0	12.0	Q1
PCA9538DWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
PCA9538PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
PCA9538PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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#### \*All dimensions are nominal

	7 ill difficiente de la Hammai											
	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)				
	PCA9538DGVR	TVSOP	DGV	16	2000	356.0	356.0	35.0				
	PCA9538DWR	SOIC	DW	16	2000	350.0	350.0	43.0				
	PCA9538PWR	TSSOP	PW	16	2000	356.0	356.0	35.0				
١	PCA9538PWR	TSSOP	PW	16	2000	356.0	356.0	35.0				

# **PACKAGE MATERIALS INFORMATION**

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## **TUBE**



### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
PCA9538DB	DB	SSOP	16	80	530	10.5	4000	4.1
PCA9538DW	DW	SOIC	16	40	506.98	12.7	4826	6.6





#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
  4. Reference JEDEC registration MO-150.





NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



7.5 x 10.3, 1.27 mm pitch

SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





SOIC



### NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
- 5. Reference JEDEC registration MS-013.



SOIC



### NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



#### NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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